

ZXMN3F31DN8 30V SO8 dual N-channel enhancement mode MOSFET

Summary

V _{(BR)DSS}	$R_{DS(on)}(\Omega)$	I _D (A)
30	0.024 @ V _{GS} = 10V	7.3
	0.039 @ V _{GS} = 4.5V	5.7



Description

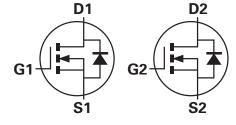
This new generation Trench MOSFET from Zetex features low onresistance achievable with 4.5V gate drive.

Features

- · Low on-resistance
- 4.5V gate drive capability

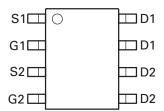
Applications

- DC-DC Converters
- · Power management functions
- · Load switching
- Motor control
- · Back lighting



Ordering information

DEVICE	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXMN3F31DN8TA	7	12	500



Device marking

ZXMN

3F31D

Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Drain source voltage	V _{DSS}	30	V
Gate source voltage	V _{GS}	±20	V
Continous Drain Current @ V _{GS} =10; T _A =25°C ^(b)	I _D	7.3	Α
@ V _{GS} =10; T _A =70°C ^(b)		5.9	Α
@ V _{GS} =10; T _A =25°C ^(a)		5.7	Α
Pulsed drain current ^(c)	I _{DM}	33	Α
Continuous source current (body diode)(b)	I _S	3.5	Α
Pulsed source current (body diode)(c)	I _{SM}	33	Α
Power dissipation at T _A =25°C ^{(a)(d)}	P _D	1.25	W
Linear derating factor		10	mW/°C
Power dissipation at T _A =25°C ^{(a)(e)}	P _D	1.8	W
Linear derating factor		14	mW/°C
Power dissipation at T _A =25°C ^{(b)(d)}	P _D	2.1	W
Linear derating factor		17	mW/°C
Operating and storage temperature range	T _j , T _{stg}	-55 to 150	°C

Thermal resistance

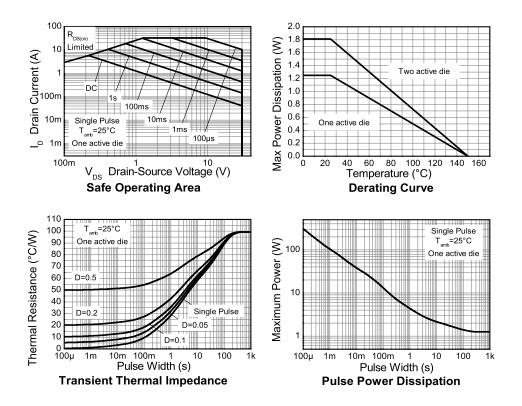
Parameter	Symbol	Limit	Unit
Junction to ambient ^{(a)(d)}	$R_{\Theta JA}$	100	°C/W
Junction to ambient ^{(a)(e)}	$R_{\Theta JA}$	70	°C/W
Junction to ambient ^{(b)(d)}	$R_{\Theta JA}$	60	°C/W
Junction to lead ^(f)	$R_{\Theta JL}$	53	°C/W

NOTES:

- (a) For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.
- (b) For a device surface mounted on FR4 PCB measured at $t \leq 10 \mbox{ sec.}$
- (c) Repetitive rating $25mm \times 25mm \text{ FR4 PCB}$, D=0.02, pulse width $300\mu s$ pulse width limited by maximum junction temperature.
- (d) For a dual device with one active die.
- (e) For a device with two active die running at equal power.
- (f) Thermal resistance from junction to solder-point (at end of drain lead).

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Thermal characteristics



Electrical characteristics (at T_{amb} = 25°C unless otherwise stated)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions	
Static			•				
Drain-Source breakdown voltage	V _{(BR)DSS}	30			V	I _D = 250μA, V _{GS} =0V	
Zero Gate voltage drain current	I _{DSS}			0.5	μА	V _{DS} = 30V, V _{GS} =0V	
Gate-Body leakage	I _{GSS}			100	nA	V _{GS} =±20V, V _{DS} =0V	
Gate-Source threshold voltage	V _{GS(th)}	1.0		3.0	V	I _D = 250μA, V _{DS} =V _{GS}	
Static Drain-Source on-state resistance (*)	R _{DS(on)}			0.024 0.039	Ω Ω	V _{GS} = 10V, I _D = 7.0A V _{GS} = 4.5V, I _D = 6.0A	
Forward transconductance ^{(*)(†)}	9 _{fs}		16.5		S	V _{DS} = 15V, I _D = 7A	
Dynamic ^(†)				•			
Input capacitance	C _{iss}		608		pF		
Output capacitance	C _{oss}		132		pF	TV _{DS} = 15V, V _{GS} =0V _f=1MHz	
Reverse transfer capacitance	C _{rss}		71		pF		
Switching (‡)(†)							
Turn-on-delay time	t _{d(on)}		2.9		ns	45)/ 1 44	
Rise time	t _r		3.3		ns	V _{DD} = 15V, I _D = 1A R _G ≅ 6.0Ω, V _{GS} =10V	
Turn-off delay time	t _{d(off)}		16		ns	- 11G = 0.032, VGS-10V	
Fall time	t _f		8		ns		
Total gate charge	Q_g		12.9		nC	V _{DS} = 15V, V _{GS} = 10V	
Gate-source charge	Q_{gs}		2.5		nC	I _D = 7A	
Gate drain charge	Q _{gd}		2.52		nC		
Source-drain diode							
Diode Forward Voltage ^(*)	V_{SD}		0.82	1.2	V	T_{j} =25°C, I_{S} = 1.7A, V_{GS} =0V	
Reverse recovery time ^(†)	t _{rr}		12		ns	T _j =25°C, I _S =2.2A	
Reverse recovery charge ^(†)	Q _{rr}		4.8		nC	di/dt=100A/μs	

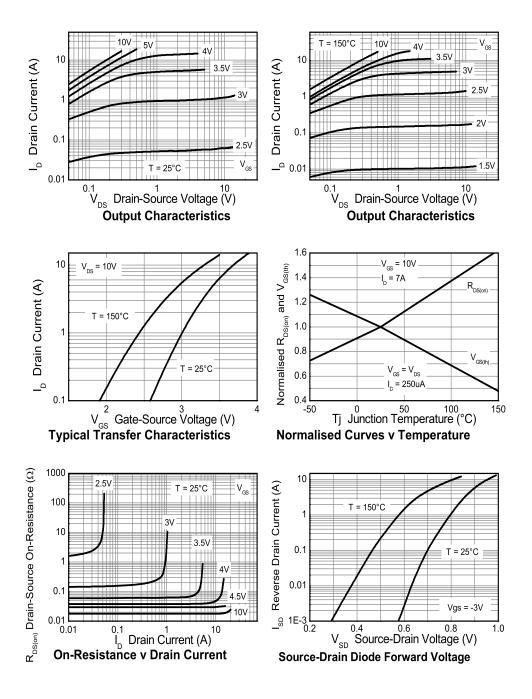
NOTES:

^(*) Measured under pulsed conditions. Pulse width \leq 300 μ s; duty cycle \leq 2%.

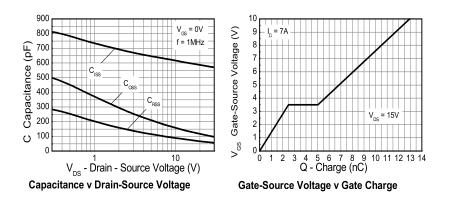
^(†) For design aid only, not subject to production testing

^(‡) Switching characteristics are independent of operating junction temperature.

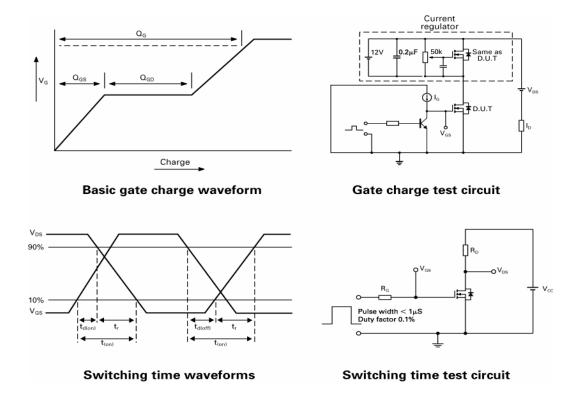
Typical characteristics



Typical characteristics

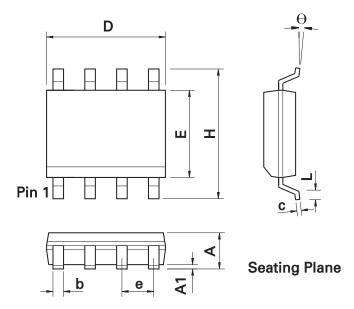


Test circuits



ZXMN3F31DN8

Package outline - SO8



DIM	Inc	hes	Millin	neters	DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
Α	0.053	0.069	1.35	1.75	е	0.050 BSC		1.27 BSC	
A1	0.004	0.010	0.10	0.25	b	0.013	0.020	0.33	0.51
D	0.189	0.197	4.80	5.00	С	0.008	0.010	0.19	0.25
Н	0.228	0.244	5.80	6.20	θ	0°	8°	0°	8°
Е	0.150	0.157	3.80	4.00	h	0.010	0.020	0.25	0.50
L	0.016	0.050	0.40	1.27	-	-	-	-	-

Note: Controlling dimensions are in inches. Approximate dimensions are provided in millimeters

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